

Prior to calculating the filing fee, please rewrite claims 1-29 and 31-37, as follows:

1. (once amended) An optical apparatus including an airtight chamber for accommodating optical elements, the optical apparatus comprising:
 - a first purge mechanism provided with said airtight chamber to supply a first gas into said airtight chamber;
 - a second purge mechanism provided with said airtight chamber to supply a second gas having a composition differing from the first gas into said airtight chamber;
 - an operation condition detecting mechanism adapted to said optical apparatus to detect an operation condition of said optical apparatus; and
 - a control apparatus connected to said first purge mechanism and said second purge mechanism to selectively connect said airtight chamber to said first purge mechanism or said second purge mechanism based on a detection result of the operation condition detecting mechanism.
2. (once amended) An optical apparatus as claimed in claim 1, further comprising a light source which emits illumination light.
3. (once amended) An optical apparatus as claimed in claim 2, wherein said light source includes an excimer laser light source which emits excimer laser light.
4. (once amended) An optical apparatus as claimed in claim 1, further comprising an illumination optical system having a plurality of optical elements and illuminating a mask with illumination light, wherein at least some of said plurality of optical elements of the illumination optical system are accommodated in said airtight chamber.

5. (once amended) An optical apparatus as claimed in claim 4, further comprising a projection optical system that projects at least part of a pattern formed on said mask onto a substrate.

6. (once amended) An optical apparatus as claimed in claim 1, wherein said first gas is inert gas, and said second gas is oxygen, which has at least the same concentration as that in the atmosphere, or mixed gas, which contains oxygen.

7. (once amended) An optical apparatus as claimed in claim 6, further comprising a cleaning apparatus arranged in a flow path of the first gas and the second gas to remove impurities from the gases.

8. (once amended) An optical apparatus as claimed in claim 1, wherein said optical apparatus includes a housing which accommodates said airtight chamber, said operation condition detecting mechanism includes an environment monitor which detects the concentration of a predetermined gas inside or outside said housing, and said control apparatus switches the purge mechanism connected to said airtight chamber from the first purge mechanism to the second purge mechanism based on the detection results of the environment monitor when the concentration of said predetermined gas falls below a predetermined value.

9. (once amended) An optical apparatus as claimed in claim 1, wherein said optical apparatus includes an exhaust apparatus connected to said airtight chamber, said operation condition detecting mechanism includes an exhaust monitor provided with said exhaust apparatus to detect the exhaust volume of said exhaust apparatus, and said control apparatus switches the purge mechanism connected to said airtight chamber from the first purge mechanism to the second purge mechanism based on the detection results of the environment monitor when said exhaust volume falls below a predetermined value.

10. (once amended) An optical apparatus as claimed in claim 1, wherein the purge mechanism connected to said airtight chamber is switched from the first purge

mechanism to the second purge mechanism when at least one of said operation condition detecting mechanism and said control apparatus is in a deactivated state.

11. (once amended) An optical apparatus as claimed in claim 1, wherein said control apparatus connects said first purge mechanism to said airtight chamber when said optical apparatus operates and connects said second purge mechanism to said airtight chamber when a condition for using said first gas is not satisfied.

12. (once amended) An optical apparatus as claimed in claim 11, wherein said second purge mechanism is connected to the airtight chamber when part of the housing accommodating said airtight chamber is in an opened state, when a power supply of said optical apparatus is off, or when said optical apparatus is being transported, assembled, or adjusted.

13. (once amended) An optical apparatus as claimed in claim 1 further comprising a holder that stores and holds said second gas.

14. (once amended) An exposure apparatus that transfers a pattern of a mask to a substrate, the exposure apparatus comprising:

a light source which emits illumination light;

an airtight chamber accommodating at least one of a plurality of optical elements disposed between said light source and said substrate;

a first purge mechanism provided with said airtight chamber to supply a first gas into said airtight chamber;

a second purge mechanism provided with said airtight chamber to supply a second gas having a composition differing from said first gas into said airtight chamber;

an operation condition detecting mechanism adapted to said exposure apparatus to detect an operation condition of said exposure apparatus; and

a control apparatus connected to said first purge mechanism and said second purge mechanism to connect said airtight chamber to said first purge mechanism or said second purge mechanism based on a detection result of the operation condition detecting mechanism.

15. (once amended) An exposure apparatus as claimed in claim 14, wherein said airtight chamber includes a first airtight chamber which accommodates the optical elements in said light source, a second airtight chamber which accommodates at least one of the optical elements disposed between said light source and said mask, and a third airtight chamber which accommodates at least one of the optical elements disposed between said mask and said substrate.

16. (once amended) An exposure apparatus as claimed in claim 14, further comprising a recovering apparatus that recovers said first gas through at least one of the housing accommodating said airtight chamber and said airtight chamber.

17. (once amended) An exposure apparatus as claimed in claim 15, wherein said second gas is chemically clean dry air.

18. (once amended) An exposure apparatus as claimed in claim 14, further comprising a sensor provided with said airtight chamber to detect the concentration of either one of said first gas or oxygen in said airtight chamber, and a light emission control apparatus connected to said light source to control said light source based on an output of said sensor.

19. (once amended) An exposure apparatus as claimed in claim 18, wherein said sensor detects said oxygen concentration, and said light emission control apparatus prohibits the emission of said illumination light from said light source until said oxygen concentration becomes less than or equal to a predetermined value.

20. (once amended) An exposure apparatus as claimed in claim 19, wherein said airtight chamber includes a plurality of airtight chambers disposed in a light path of said illumination light, a plurality of sensors are provided in each of said plurality of airtight chambers, and said light emission control apparatus controls said light source based on outputs of said plurality of sensors.

21. (once amended) An exposure apparatus as claimed in claim 20, further comprising an illumination optical system illuminating said mask with said illumination light, a projection optical system projecting at least part of said mask pattern, which is illuminated with said illumination light, onto said substrate, and a transmission system disposed between said light source and said illumination optical system, wherein said plurality of airtight chambers includes at least one of a first airtight chamber provided in said light source, a second airtight chamber accommodating at least one of optical elements forming said illumination optical system, a third airtight chamber accommodating at least one of optical elements forming said projection optical system, and a fourth airtight chamber accommodating at least one of optical elements forming said transmission system.

22. (once amended) An exposure apparatus as claimed in claim 20, wherein said exposure apparatus includes an illumination optical system which illuminates said mask with said illumination light, and said airtight chamber includes at least two airtight chambers which accommodates the optical elements of the illumination optical system, wherein said at least two airtight chambers are each provided with a sensor.

23. (once amended) An exposure apparatus as claimed in claim 14, wherein said control apparatus connects said airtight chamber to said second purge mechanism in order to supply said second gas into the airtight chamber when the emission of said illumination light from said light source is interrupted or stopped.

24. (once amended) An exposure apparatus as claimed in claim 23, further comprising a housing which accommodates said airtight chamber and an exhaust apparatus connected to said housing and operated when said second gas is supplied.

25. (once amended) An exposure apparatus as claimed in claim 24, further comprising an environment sensor provided with said housing to detect the environment in said housing, wherein said exhaust apparatus is controlled based on an output of said environment sensor.

26. (once amended) An exposure apparatus as claimed in claim 24, wherein said housing includes either a first chamber which accommodates said light source or a second chamber which accommodates the exposure apparatus main body.

27. (once amended) A laser light source used in an exposure apparatus that transfers a pattern of a mask onto a substrate, the laser light source comprising:

a tank which stores a second gas, which has a composition differing from a first gas that is supplied during the operation of said exposure apparatus; and

 piping connected to the laser light source to introduce said second gas into the laser light source when the laser light source is separated from said exposure apparatus.

28. (once amended) A gas supply method for supplying a predetermined gas to an airtight chamber, which accommodates optical elements and is disposed in an optical apparatus, the gas supply method comprising the steps of:

detecting an operation condition of said optical apparatus;

selectively supplying the airtight chamber with a first gas or a second gas, the composition of which differs from the first gas, as said predetermined gas based on the detection result.

29. (once amended) A gas supply method as claimed in claim 28, wherein said first gas is inert gas, and said second gas is oxygen, which has at least the same concentration as that in the atmosphere, or mixed gas, which contains oxygen.

31. (once amended) A gas supply method as claimed in claim 29, wherein said optical apparatus includes an exhaust apparatus connected to said airtight chamber, the gas supply method comprising the steps of:

detecting an exhaust volume of said exhaust apparatus; and

supplying said first gas to said airtight chamber when said exhaust volume is greater than or equal to a predetermined value, and supplying said second gas to said airtight chamber when the gas concentration falls below said predetermined value.

32. (once amended) A gas supply method as claimed in claim 29, wherein said first gas is supplied to said airtight chamber when said optical apparatus is operated.

33. (once amended) A gas supply method as claimed in claim 32, wherein said second gas is supplied to said airtight chamber when said airtight chamber or part of a housing accommodating the airtight chamber is opened or when a power supply of the optical apparatus is off.

34. (once amended) A gas supply method as claimed in claim 29, wherein said optical apparatus includes an illumination optical system which illuminates a mask with illumination light from a light source, a projection optical system which projects at least part of a pattern of the mask illuminated with said illumination light onto a photosensitive substrate, and a transmission system disposed between said light source and said illumination optical system, wherein said airtight chamber is provided in at least one of said illumination optical system, said projection optical system, and said transmission system.

35. (once amended) An exposure method comprising the step of:
projecting a pattern of a mask onto a substrate using a gas supply method for supplying a predetermined gas to an airtight chamber, which accommodates optical elements and is disposed in an optical apparatus, the gas supply method including the steps of:

detecting an operation condition of said optical apparatus; and
selectively supplying the airtight chamber with a first gas or a second gas,
the composition of which differs from the first gas, as said predetermined gas based on
the detection result.

36. (once amended) An exposure method for projecting a pattern formed on a mask onto a substrate, the exposure method comprising the step of:

supplying a first gas to said airtight chamber using the gas supply method for supplying a predetermined gas to an airtight chamber, which accommodates optical

elements and is disposed in an optical apparatus before projecting said pattern onto said substrate, the gas supply method including the steps of:

detecting an operation condition of said optical apparatus; and

selectively supplying the airtight chamber with a first gas or a second gas, the composition of which differs from the first gas, as said predetermined gas based on the detection result, wherein said first gas is inert gas, and said second gas is oxygen, which has at least the same concentration as that in the atmosphere, or mixed gas, which contains oxygen, and wherein said first gas is supplied to said airtight chamber when said optical apparatus is operated.

37. (once amended) A device manufacturing method comprising the steps of:

supplying a first gas to said airtight chamber using the gas supply method; and
projecting a pattern formed on a mask onto a substrate, the gas supply method
including the steps of:

detecting an operation condition of said optical apparatus; and

selectively supplying the airtight chamber with a first gas or a second gas, the composition of which differs from the first gas, as said predetermined gas based on the detection result, wherein said first gas is inert gas, and said second gas is oxygen, which has at least the same concentration as that in the atmosphere, or mixed gas, which contains oxygen, and wherein said first gas is supplied to said airtight chamber when said optical apparatus is operated.

Remarks

The claims have been rewritten to eliminate multiple claim dependency and place them in better form for examination, and the specification has been amended to include US-style headings.